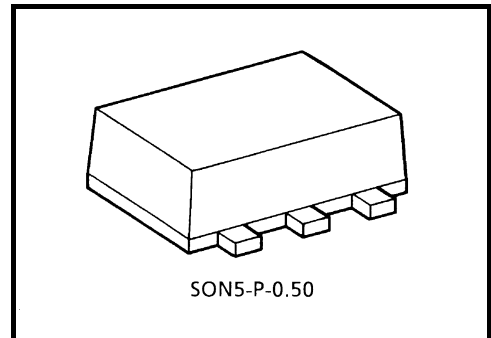


# TC7SZ125AFE

## Bus Buffer with 3-STATE Output

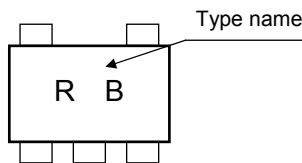
### Features

- High output drive:  $\pm 24$  mA (min) at  $V_{CC} = 3$  V
- Super high speed operation:  $t_{pd}$  2.6 ns (typ.)  
at  $V_{CC} = 5$  V, 50pF
- Operation voltage range:  $V_{CC(opr)} = 1.8\sim 5.5$  V
- 5.5-V tolerant inputs
- Matches the performance of TC74LCX series when operated at 3.3-V  $V_{CC}$ .

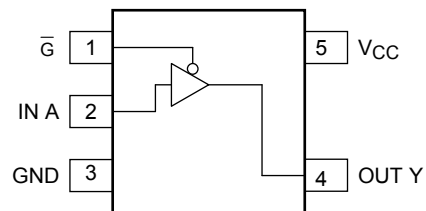


Weight: 0.003 g (typ.)

### Marking



### Pin Assignment (top view)



### Absolute Maximum Ratings ( $T_a = 25^\circ\text{C}$ )

Characteristics	Symbol	Rating	Unit
Power supply voltage	$V_{CC}$	-0.5~6	V
DC input voltage	$V_{IN}$	-0.5~6	V
DC output voltage	$V_{OUT}$	-0.5~ $V_{CC} + 0.5$	V
Input diode current	$I_{IK}$	-20	mA
Output diode current	$I_{OK}$	$\pm 20$	mA
DC output current	$I_{OUT}$	$\pm 50$	mA
DC $V_{CC}$ /ground current	$I_{CC}$	$\pm 50$	mA
Power dissipation	$P_D$	150	mW
Storage temperature	$T_{stg}$	-65~150	$^\circ\text{C}$
Lead temperature (10s)	$T_L$	260	$^\circ\text{C}$

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

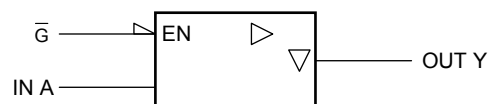
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

## Truth Table

A	$\bar{G}$	Y
X	H	Z
L	L	L
H	L	H

X : Don't Care  
Z : High Impedance

## Logic Diagram



## Operating Ranges

Characteristics	Symbol	Rating	Unit
Supply voltage	$V_{CC}$	1.8~5.5	V
		1.5~5.5 (Note 1)	
Input voltage	$V_{IN}$	0~5.5	V
Output voltage	$V_{OUT}$	0~ $V_{CC}$	V
Operating temperature	$T_{opr}$	-40~85	°C
Input rise and fall time	dt/dv	0~20 ( $V_{CC} = 1.8\text{ V}, 2.5\text{ V} \pm 0.2\text{ V}$ )	ns/V
		0~10 ( $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$ )	
		0~5 ( $V_{CC} = 5.5\text{ V} \pm 0.5\text{ V}$ )	

Note1 : Data retention only

## Electrical Characteristics

### DC Characteristics

Characteristics		Symbol	Test Condition	Ta = 25°C			Ta = -40~85°C		Unit				
				V <sub>CC</sub> (V)	Min	Typ.	Max	Min		Max			
Input voltage	High level	V <sub>IH</sub>	—	1.8	0.75 × V <sub>CC</sub>	—	—	0.75 × V <sub>CC</sub>	—	V			
				2.3~5.5	0.7 × V <sub>CC</sub>	—	—	0.7 × V <sub>CC</sub>	—				
	Low level	V <sub>IL</sub>		1.8	—	—	0.25 × V <sub>CC</sub>	—	0.25 × V <sub>CC</sub>				
				2.3~5.5	—	—	0.3 × V <sub>CC</sub>	—	0.3 × V <sub>CC</sub>				
Output voltage	High level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -100 μA	1.8	1.7	1.8	—	1.7	—	V		
					2.3	2.2	2.3	—	2.2	—			
					3.0	2.9	3.0	—	2.9	—			
					4.5	4.4	4.5	—	4.4	—			
				I <sub>OH</sub> = -8 mA	2.3	1.9	2.15	—	1.9	—			
					3.0	2.4	2.8	—	2.4	—			
					4.5	2.3	2.68	—	2.3	—			
	I <sub>OH</sub> = -32 mA	2.3		1.9	2.15	—	1.9	—					
		3.0		2.4	2.8	—	2.4	—					
		4.5		3.8	4.2	—	3.8	—					
		Low level		V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IL</sub>	I <sub>OL</sub> = 100 μA	1.8	—	0	0.1		—	0.1
							2.3	—	0	0.1		—	0.1
							3.0	—	0	0.1		—	0.1
							4.5	—	0	0.1		—	0.1
I <sub>OL</sub> = 8 mA	2.3	—	0.1	0.3		—	0.3						
	3.0	—	0.15	0.4		—	0.4						
	4.5	—	0.22	0.55		—	0.55						
	I <sub>OL</sub> = 32 mA	2.3	—	0.15		0.4	—	0.4					
3.0		—	0.22	0.55		—	0.55						
4.5		—	0.22	0.55		—	0.55						
4.5		—	0.22	0.55		—	0.55						
Input leakage current		I <sub>IN</sub>	V <sub>IN</sub> = 5.5 V or GND	0~5.5		—	—	±1	—	±10	μA		
3-state output off-state current		I <sub>OZ</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> , V <sub>OUT</sub> = 0~5.5 V	1.8~5.5		—	—	±1	—	±10	μA		
Quiescent supply current		I <sub>CC</sub>	V <sub>IN</sub> = 5.5 V or GND	5.5		—	—	2	—	20	μA		

**AC Characteristics (unless otherwise specified, Input:  $t_r = t_f = 3$  ns)**

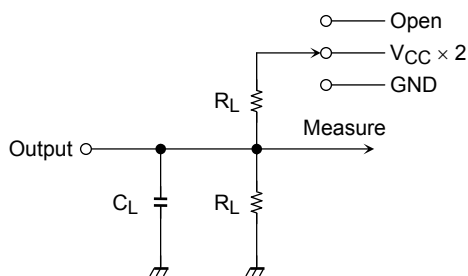
Characteristics	Symbol	Test Condition	Ta = 25°C			Ta = -40~85°C		Unit	
			V <sub>CC</sub> (V)	Min	Typ.	Max	Min		Max
Propagation delay time	$t_{pLH}$ $t_{pHL}$	$C_L = 15$ pF, $R_L = 1$ M $\Omega$	1.8	2.0	5.3	11.0	2.0	11.5	ns
			$2.5 \pm 0.2$	0.8	3.4	7.5	0.8	8.0	
			$3.3 \pm 0.3$	0.5	2.5	5.2	0.5	5.5	
		$C_L = 50$ pF, $R_L = 500$ $\Omega$	$5.0 \pm 0.5$	0.5	2.1	4.5	0.5	4.8	
			$3.3 \pm 0.3$	1.5	3.2	5.7	1.5	6.0	
			$5.0 \pm 0.5$	0.8	2.6	5.0	0.8	5.3	
Output enable time	$t_{pZL}$ $t_{pZH}$	$C_L = 50$ pF, $R_L = 500$ $\Omega$	1.8	2.0	7.0	12.5	2.0	13.0	ns
			$2.5 \pm 0.2$	1.5	4.6	8.5	1.5	9.0	
			$3.3 \pm 0.3$	1.5	3.5	6.2	1.5	6.5	
			$5.0 \pm 0.5$	0.8	2.8	5.5	0.8	5.8	
Output disable time	$t_{pLZ}$ $t_{pHZ}$	$C_L = 50$ pF, $R_L = 500$ $\Omega$	1.8	2.0	5.4	11.0	2.0	12.0	ns
			$2.5 \pm 0.2$	1.5	3.5	8.0	1.5	8.5	
			$3.3 \pm 0.3$	1.0	2.8	5.7	1.0	6.0	
			$5.0 \pm 0.5$	0.5	2.1	4.7	0.5	5.0	
Input capacitance	C <sub>IN</sub>	—	0~5.5	—	4	—	—	—	pF
Power dissipation capacitance	C <sub>PD</sub>	(Note 2)	3.3	—	20	—	—	—	pF
			5.5	—	27	—	—	—	

Note2: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$I_{CC (opr.)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$$

**AC Characteristics Measurement Circuit**



Characteristics	Switch
$t_{pLH}$ , $t_{pHL}$	Open
$t_{pLZ}$ , $t_{pZL}$	V <sub>CC</sub> × 2
$t_{pHZ}$ , $t_{pZH}$	GND



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